Search Notes



	Appli	cation	/Contro	l No.
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Applicant(s)/Patent under Reexamination

10/801,215

Examiner

HOCHSTEIN ET AL. Art Unit

1746

Saeed T. Chaudhry

SEARCHED				
Subclass	Date	Examiner		
184 186 166R 166C	4/12/2007	da		
379 390 395	4/12/2007	7		
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	Subclass 184 186 166R 166C 379 390 395	Subclass Date 184 186 166R 166C 379 390 4/12/2007 395		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
134	166R 166C	4/12/2007	Ar	
134	184 186	7	7	
122	379			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
·	DATE	EXMR		
PGPUB;134/186,166R,166C.ccls. and (ion with shockwave) or (ion with sensor)	4/12/2007	Sha		
122/379,390,395.ccls. and (ion with sensor) or (ion with shockwave)	4/12/2007			
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